

BAT 49

SMALL SIGNAL SCHOTTKY DIODE

DO 41

(Glass)

DESCRIPTION

General purpose metal to silicon diode featuring very low turn-on voltage and fast switching. This device has integrated protection against excessive voltage such as electrostatic discharges.

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter	Value	Unit		
V _{RRM}	Repetitive Peak Reverse Voltage	80	V		
lF	Forward Continuous Current*	500	mA		
I _{FRM}	Repetitive Peak Forward Current*	3	A		
I _{FSM}	Surge non Repetitive Forward Current*	10	А		
T _{stg} Tj	Storage and Junction Temperature Range	- 65 to 150 - 65 to 125	°C °C		
ΤL	Maximum Lead Temperature for Soldering during 10s at 4mm 230 from Case 230				

THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
R _{th(j-a)}	Junction-ambient*	110	°C/W

ELECTRICAL CHARACTERISTICS

STATIC CHARACTERISTICS

Symbol		Test Conditions	Min.	Тур.	Max.	Unit
I _R * *	T _j = 25°C	V _R = 80V			200	μΑ
V _F * *	T _j = 25°C	$I_F = 10 \text{mA}$			0.32	V
	T _j = 25°C	I _F = 100mA			0.42	
	$T_j = 25^{\circ}C$	I _F = 1A			1	

DYNAMIC CHARACTERISTICS

Symbol	Test Conditions				Тур.	Max.	Unit
С	T _j = 25°C	f = 1MHz	$V_R = 0V$		120		pF
			$V_R = 5V$		35		

* On infinite heatsink with 4mm lead length ** Pulse test: $t_p \leq 300 \mu s ~~\delta < 2 \%$.

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Figure 1. Forward current versus forward voltage at low level (typical values).

Figure 2. Forward current versus forward voltage at high level (typical values).



Figure 3. Reverse current versus junction temperature.



Figure 4. Reverse current versus $V_{\mbox{\scriptsize RRM}}$ in per cent.





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Figure 5. Capacitance C versus reverse applied voltage V_{R} (typical values).



Figure 6. Surge non repetitive forward current for a rectangular pulse with $t \leq$ 10 ms.



Figure 7. Surge non repetitive forward current versus number of cycles.







PACKAGE MECHANICAL DATA

DO 41 Glass

$B \qquad A \qquad B \qquad \phi C $								
		DIMEN	SIONS					
REF.	Millim	neters	Inc	hes	NOTES			
	Min. Max. Min. Max.							
Α	4.070	5.200	0.160	0.205	1 - The lead diameter \varnothing D is not controlled over zone E			
В	28		1.102					
ØC	2.040	2.710	0.080	0.107	2 - The minimum axial lengh within which the device may b			
ØD	0.712	0.863	0.028	0.034	placed with its leads bent at right angles is 0.59"(15 mm)			
Е		1.27		0.050				

Cooling method : by convection and conduction Marking: clear, ring at cathode end. Weight: 0.34g

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